

Innovating Energy Technology

http://www.fujielectric.com/products/semiconductor/ **FUJI POWER MOSFET**

Super J MOS[®] S2 series

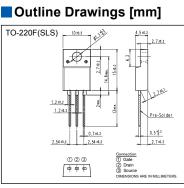
N-Channel enhancement mode power MOSFET

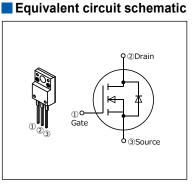
Features

Pb-free lead terminal **RoHS** compliant uses Halogen-free molding compound

Applications

For switching





Absolute Maximum Ratings at Tc=25°C (unless otherwise specified)

Parameter	Symbol	Characteristics	Unit	Remarks
Durain Source Veltone	V _{DS}	600	V	
Drain-Source Voltage	V _{DSX}	600	V	V _{GS} =-30V
Continuous Dusin Connent	I _D	30.1	А	Tc=25°C Note*1,2
Continuous Drain Current		19	А	Tc=100°C Note*1,2
Pulsed Drain Current	I _{DP}	90.8	А	Note *2
Gate-Source Voltage	V _{GS}	±30	V	
Non-Repetitive Maximum Avalanche Current	las	3.5	А	Note *3
Non-Repetitive Maximum Avalanche Energy	Eas	748	mJ	Note *4
Maximum Drain-Source dV/dt	dV _{DS} /dt	50	V/ns	V _{DS} ≤ 600V
Continuous	4	30.1	А	Tc=25°C Note*1,2
Diode Forward Current	Isd	19	А	Tc=100°C Note*1,2
Pulsed Diode Forward Current	ISDP	90.8	А	Note *2
Peak Diode Recovery dV/dt	dV/dt	15	V/ns	Note *5
Peak Diode Recovery -di/dt	-di/dt	100	A/µs	Note *6
	_	2.16		<i>T</i> _a =25°C
Maximum Power Dissipation	PD	57	W	<i>T</i> c=25°C
On anothing and Stangers Tampanatum and the	Tch	150	°C	
Operating and Storage Temperature range	T _{stg}	-55 to +150	°C	
Isolation Voltage (TO-220F)	Viso	2	kVrms	t=60sec,f=60Hz

Note *1 : Maximum duty cycle D=0.57 Note *2 : Limited by maximum channel temperature. Note *3 : 7ch≤150°C, See Fig.1 and Fig.2 Note *4 : Starting 7ch=25°C, IAs=2.1A, L=311mH, Vob=60V, Rc=50Ω, See Fig.1 and Fig.2 Eas limited by maximum channel temperature and avalanche current.

Note *5 : Iso522.7A, -di/dts100A/µs, Vos peak≤600V, 7ch≤150°C. Note *6 : Iso522.7A, dV/dt≤15V/ns, Vos peak≤600V, 7ch≤150°C.

Electrical Characteristics at T_c=25°C (unless otherwise specified) Static Ratings

Parameter	Symbol	Conditions		Min.	Тур.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I⊳=250µA		600	-	-	V
Gate Threshold Voltage	V _{GS(th)}	V _{DS} =V _{GS} I _D =1.22mA		3.5	4.0	4.5	V
Zero Gate Voltage Drain Current	Ioss	V _{DS} =600V V _{GS} =0V	T _{ch} =25°C	-	-	25	μA
		V _{DS} =480V V _{GS} =0V	<i>T</i> _{ch} =125°C	-	-	250	
Gate-Source Leakage Current	Igss	V _{DS} =0V V _{GS} = ± 30V		-	10	100	nA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} =10V I⊳=11.4A		-	0.114	0.125	Ω
Gate resistance	RG	f=1MHz, open drain		-	8.3	-	Ω

Dynamic Ratings

Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Forward Transconductance	g _{fs}	V _{DS} =25V I _D =11.4A	7.5	15	-	S
Input Capacitance	Ciss	V _{DS} =400V	-	1240	-	
Output Capacitance	Coss	V _{GS} =0V	-	42	-	
Reverse Transfer Capacitance	Crss	f=250kHz	-	6.3	-	
Effective output capacitance, energy related (Note *7)	Co(er)	V _{DS} =0400V V _{GS} =0V	-	102	-	pF
Effective output capacitance, time related (Note *8)	Co(tr)	V₀s=0400V V₀s=0V I₀=constant	- 391 -	-		
	t _{d(on)}		-	21	-	- ns
Turn-On Time	tr		-	78	-	
Turn Off Time	td(off)		-	101	-	
Turn-Off Time	<i>t</i> r		-	24	-	
Total Gate Charge	QG		-	53	-	nC
Gate-Source Charge	Q _{GS}	V_{DD} =400V, V_{GS} =10V	-	20	-	
Gate-Drain Charge	QGD	_ /₀=22.7A See Fig.5	-	20	-	
Drain-Source crossover Charge	Qsw		-	13	-	1

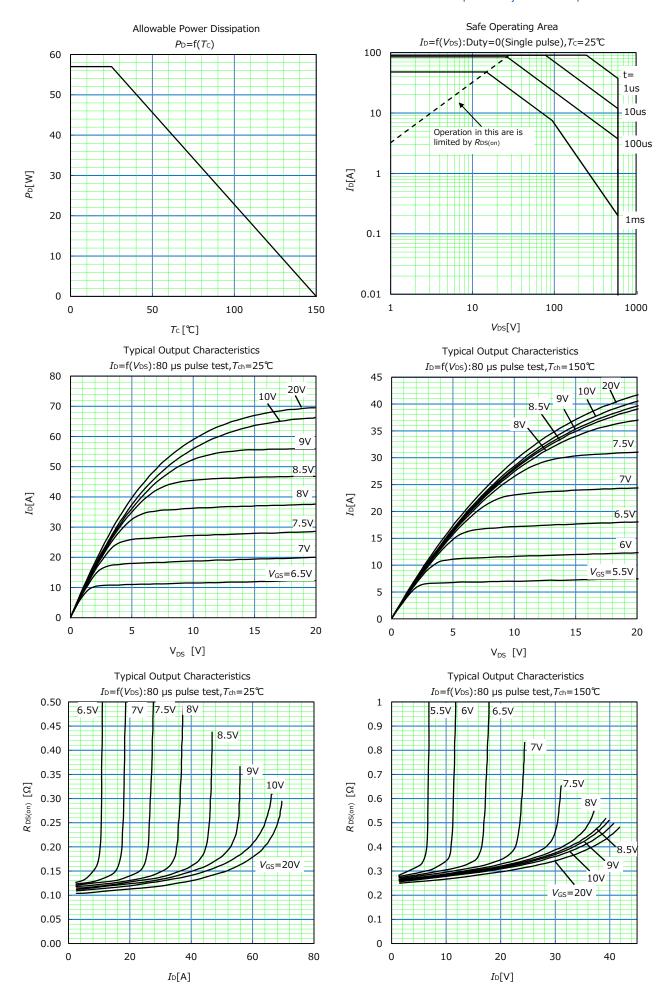
Note *7 : $C_{0(er)}$ is a fixed capacitance that gives the same stored energy as C_{oss} while V_{DS} is rising from 0 to 400V. Note *8 : $C_{0(er)}$ is a fixed capacitance that gives the same charging times as C_{oss} while V_{DS} is rising from 0 to 400V.

Reverse Diode

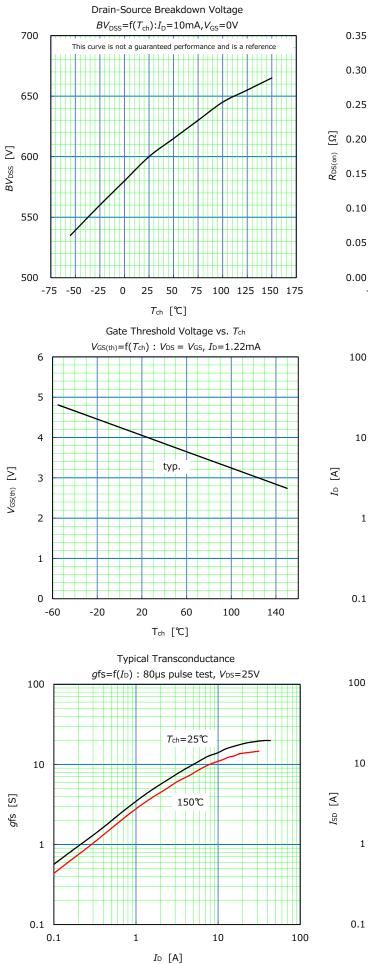
Parameter	Symbol	Conditions	Min.	Тур.	Max.	Unit
Diode Forward On-Voltage	V _{SD}	I _{SD} =22.7A, V _{GS} =0V T _{ch} =25°C	-	0.90	1.35	V
Reverse Recovery Time	trr	- V₀₀=400V, /₅₀=22.7A -di/dt=100A/μs T₅h=25°C See Fig.6 and Fig.7	-	310	-	ns
Reverse Recovery Charge	Qrr		-	4.4	-	μC
Peak Reverse Recovery Current	I rp		-	27	-	А

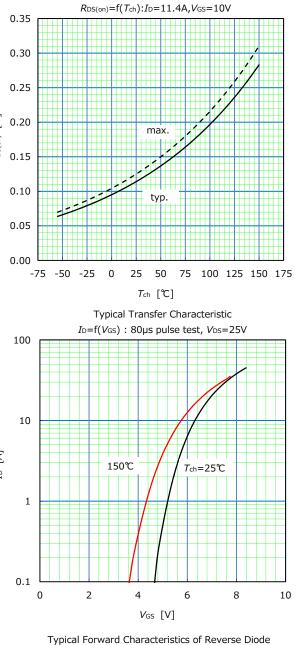
Thermal Resistance

Parameter	Symbol	Min.	Тур.	Max.	Unit
Channel to Case	Rth(ch-c)	-	-	2.193	°C/W
Channel to Ambient	Rth(ch-a)	-	-	58	°C/W

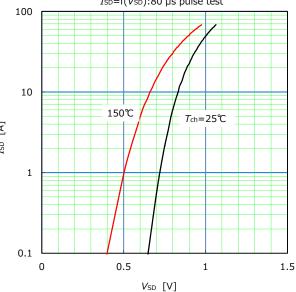


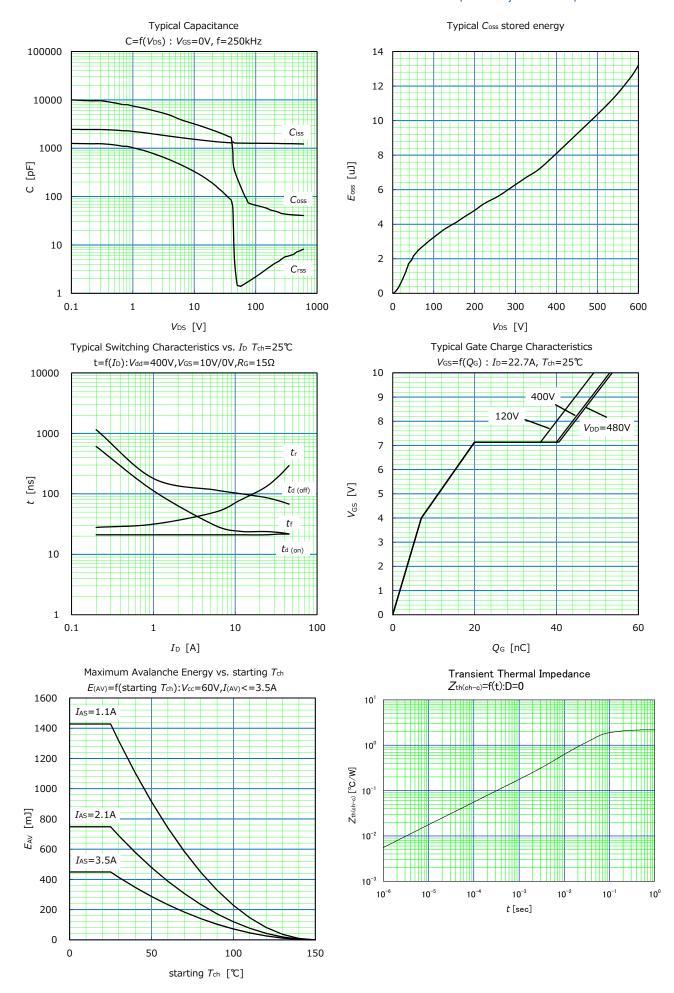
Drain-Source On-state Resistance





 $I_{SD}=f(V_{SD}):80 \ \mu s \ pulse \ test$





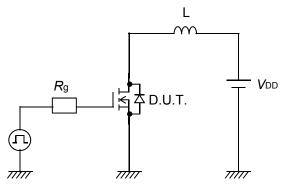


Fig.1 Avalanche Test circuit

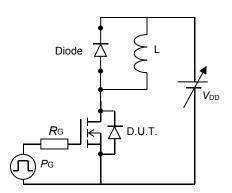


Fig.3 Switching Test circuit



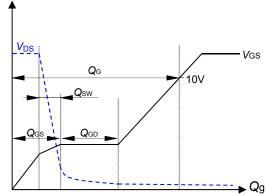
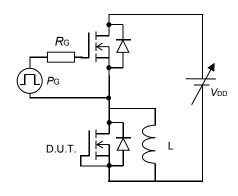
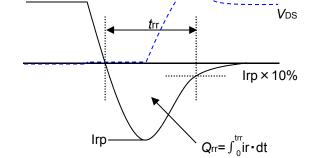


Fig.5 Operating waveform of Gate charge Test





. VDS peak

Fig.6 Reverse recovery Test circuit

Fig.7 Operating waveform of Reverse recovery Test

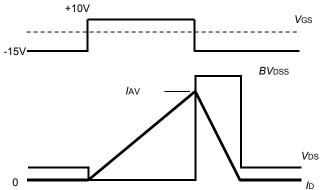


Fig.2 Operating waveforms of Avalanche Test

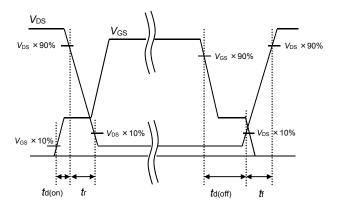


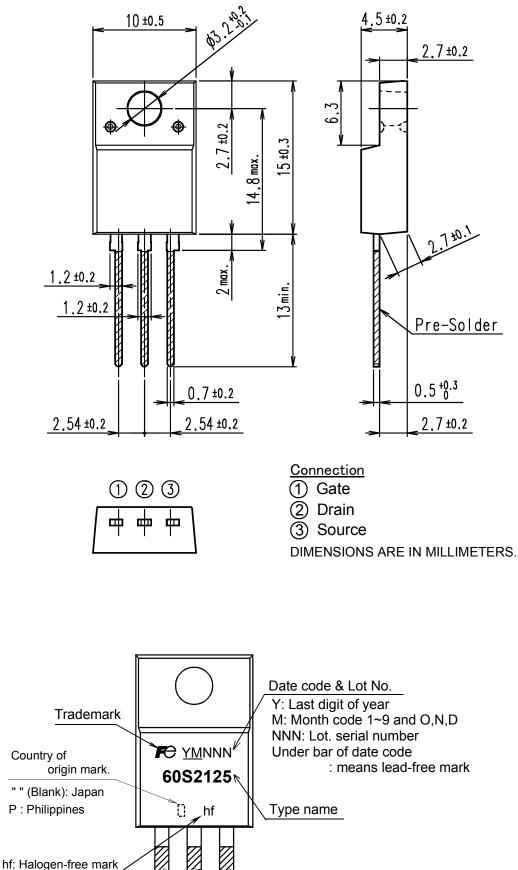
Fig.4 Operating waveform of Switching Test

Isd

Marking

http://www.fujielectric.com/products/semiconductor/

Outview: TO220F(SLS) Package



* The font (font type,size) and the trademark-size might be actually different.

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